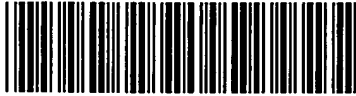


**Search Notes**

Application/Control No.

10/772,017

Examiner

Dieu-Minh Le

Applicant(s)/Patent under  
Reexamination

STAGER ET AL.

Art Unit

2114

**SEARCHED**

Class	Subclass	Date	Examiner
714	2	7/5/2006	DML
714	13	7/5/2006	DML

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search files USPAT, USOCR, USPGPUB, EPO, JPO, DERWENT, IBM-TDB.	7/5/2006	DML
Inventor name search	7/5/2006	DML